

Description

The AP3N06MI uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = 60V I_D = 3A$

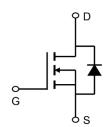
 $R_{DS(ON)} < 75 m\Omega$ @ V_{GS} =10V

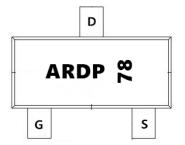
Application

Battery protection

Load switch

Uninterruptible power supply







Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP3N06MI	SOT-23-3L	ARDP 78	3000

Absolute Maximum Ratings (T_C=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	60	V
Vgs	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	3	А
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	2.1	А
Ірм	Pulsed Drain Current ²	50	А
EAS	Single Pulse Avalanche Energy ³	11	mJ
las	Avalanche Current	15	А
P _D @T _C =25°C	Total Power Dissipation ⁴	42	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
ReJA	Thermal Resistance Junction-ambient ¹	62	°C/W
Rejc	Thermal Resistance Junction-Case ¹	3	°C/W



Electrical Characteristics (T_A=25 °C unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V	
		V _{GS} =10V , I _D =5A		55	75		
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =5A		65	90	mΩ	
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250uA$	1.2		2.5	V	
IDSS	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =25°C			1	uA	
		V _{DS} =48V , V _{GS} =0V , T _J =55°C			5		
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =5A		7		S	
Qg	Total Gate Charge (10V)			5.5			
Qgs	Gate-Source Charge	V _{DS} =12V , V _{GS} =10V , I _D =5A		1.8		nC	
Qgd	Gate-Drain Charge			2.4			
T _{d(on)}	Turn-On Delay Time			6			
Tr	Rise Time	V _{DD} =12V , V _{GS} =10V ,		10			
Td(off)	Turn-Off Delay Time	—R _G =3.3 I _D =5A		15		ns	
T _f	Fall Time	ID-5A		7			
Ciss	Input Capacitance			695			
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		148		pF	
Crss	Reverse Transfer Capacitance			7			
Is	Continuous Source Current ^{1,5}				17	Α	
Ism	Pulsed Source Current ^{2,5}	─V _G =V _D =0V , Force Current			50	Α	
Vsp	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V	

Note:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =15A
- 4. The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

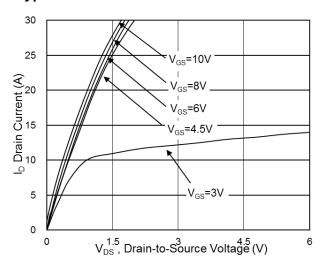


Fig.1 Typical Output Characteristics

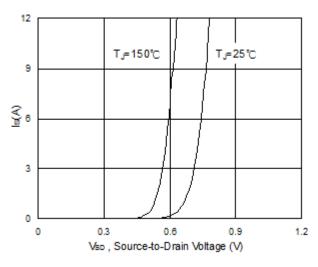


Fig.3 Forward Characteristics of Reverse

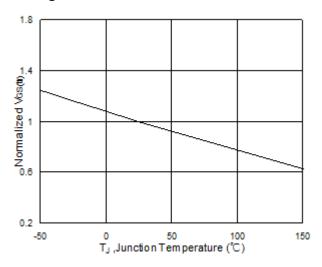


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

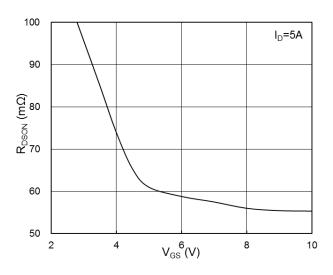


Fig.2 On-Resistance vs. Gate-Source Voltage

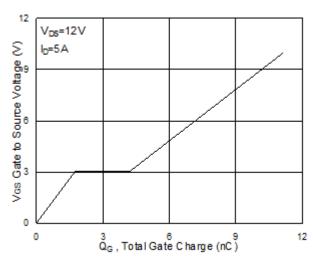


Fig.4 Gate-Charge Characteristics

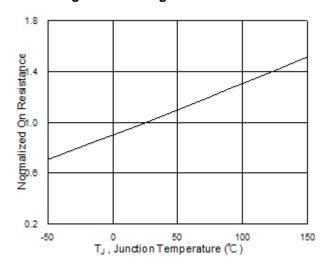
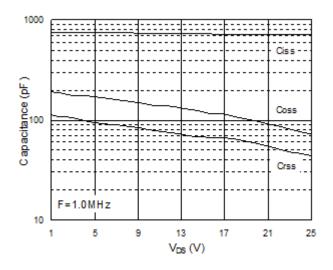


Fig.6 Normalized R_{DSON} vs. T_{J}







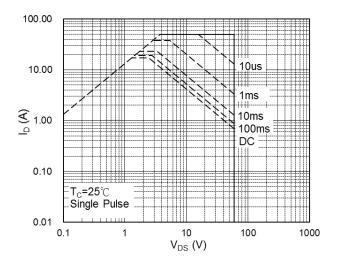


Fig.7 Capacitance

Fig.8 Safe Operating Area

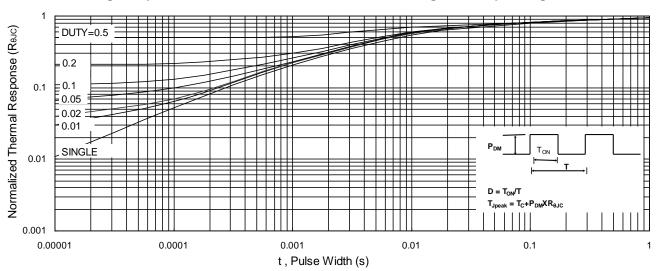


Fig.9 Normalized Maximum Transient Thermal Impedance

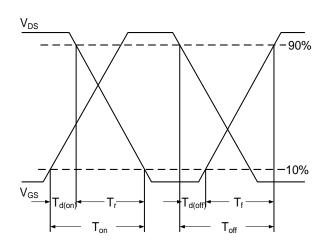


Fig.10 Switching Time Waveform

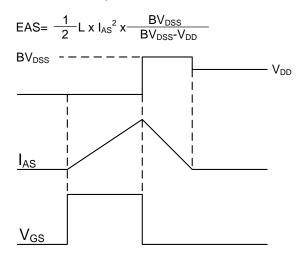
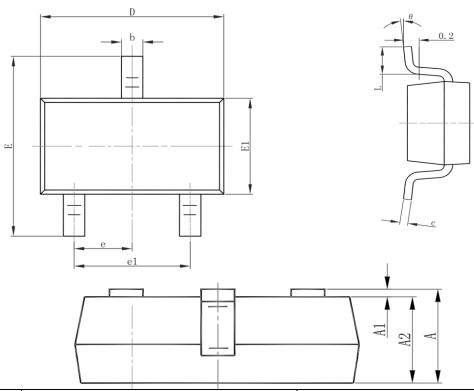


Fig.11 Unclamped Inductive Switching Waveform





Package Mechanical Data-SOT23-3



Come le el	Dimensions In Millimeters		Dimensions In Inches	
Symbol	Min.	Max.	Min.	Max.
Α	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
Е	2.650	2.950	0.104	0.116
е	0.950(BSC)		0.03	7(BSC)
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°



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AP3N06MI

60V N-Channel Enhancement Mode MOSFET

Edition	Date	Change
Rve1.0	2018/1/31	Initial release
Rve3.8	2019/2/31	Cut dowm Rds

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